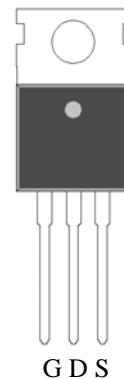


## N-Channel Enhancement Mode Power MOSFET

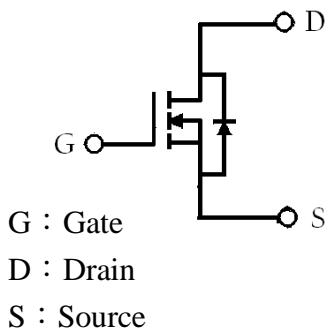
### Features:

- Low Gate Charge
- Simple Drive Requirement
- Fast Switching Characteristic
- RoHS compliant package

TO-220



$BV_{DSS}$	30V
$I_D @ V_{GS}=10V$	203A
$R_{DS(on)}(TYP) @ V_{GS}=10V, I_D=30A$	2mΩ
$R_{DS(on)}(TYP) @ V_{GS}=4.5V, I_D=20A$	2.6mΩ



### Ordering Information

Device	Package	Shipping
KWB1D7N03E3	TO-220 (Pb-free lead plating package)	50 pcs/tube, 20 tubes/box, 4 boxes / carton

## Absolute Maximum Ratings ( $T_C=25^\circ C$ , unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	$V_{DS}$	30	<b>V</b>
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current @ $T_C=25^\circ C$ , $V_{GS}=10V$ (silicon limit)	$I_D$	203	<b>A</b>
Continuous Drain Current @ $T_C=100^\circ C$ , $V_{GS}=10V$ (silicon limit)		144	
Continuous Drain Current @ $T_C=25^\circ C$ , $V_{GS}=10V$ (package limit) (Note 1)		120	
Pulsed Drain Current (Note 3)	$I_{DM}$	600	<b>A</b>
Continuous Drain Current @ $T_A=25^\circ C$ , $V_{GS}=10V$ (Note 2)	$I_{DSM}$	20	
Continuous Drain Current @ $T_A=70^\circ C$ , $V_{GS}=10V$ (Note 2)		16	
Avalanche Current (Note 3)	$I_{AS}$	80	<b>mJ</b>
Avalanche Energy @ $L=100\mu H$ , $I_D=80A$ , $R_G=25\Omega$ (Note 2)	$E_{AS}$	320	
Power Dissipation $T_C=25^\circ C$ (Note 1)	$P_D$	214	<b>W</b>
Power Dissipation $T_C=100^\circ C$ (Note 1)		107	
Power Dissipation $T_A=25^\circ C$ (Note 2)	$P_{DSM}$	2	<b>W</b>
Power Dissipation $T_A=70^\circ C$ (Note 2)		1.3	
Operating Junction and Storage Temperature	$T_j, T_{stg}$	-55~+175	$^\circ C$

## Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{th,j-c}$	0.7	$^\circ C/W$
Thermal Resistance, Junction-to-ambient, max, $t \leq 10s$ (Note 1)	$R_{th,j-a}$	15	$^\circ C/W$
Thermal Resistance, Junction-to-ambient, max (Note 1)		62.5	$^\circ C/W$

- Note : 1. The power dissipation  $P_D$  is based on  $T_{j(MAX)}=175^\circ C$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.  
 2. The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2 oz. copper, in a still air environment with  $T_A=25^\circ C$ . The power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of  $150^\circ C$ . The value in any given application depends on the user's specific board design, and the maximum temperature of  $175^\circ C$  may be used if the PCB allows it.  
 3. Repetitive rating, pulse width limited by junction temperature  $T_{j(MAX)}=175^\circ C$ . Ratings are based on low frequency and low duty cycles to keep initial  $T_j=25^\circ C$ .  
 4. The maximum current limited by package is 120A.  
 5. The static characteristics are obtained using <300μs pulses, duty cycle 0.5% maximum.  
 6. The  $R_{\theta JA}$  is the sum of thermal resistance from junction to case  $R_{\theta JC}$  and case to ambient.

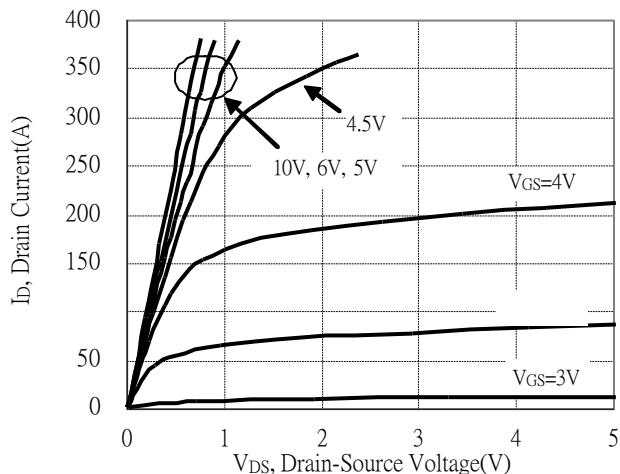
**Characteristics (Tc=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BVDSS	30	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	1.3	1.9	2.5		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA
G <sub>FS</sub>	-	52	-	S	V <sub>DS</sub> =5V, I <sub>D</sub> =20A
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V
	-	-	5		V <sub>DS</sub> =24V, V <sub>GS</sub> =0V, T <sub>j</sub> =55°C
*R <sub>DSS(ON)</sub>	-	2	2.6	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =30A
	-	2.6	3.8		V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A
<b>Dynamic</b>					
*Q <sub>g</sub>	-	41	-	nC	I <sub>D</sub> =15A, V <sub>DS</sub> =15V, V <sub>GS</sub> =4.5V
*Q <sub>gs</sub>	-	14	-		
*Q <sub>gd</sub>	-	17	-		
*t <sub>d(ON)</sub>	-	30	-	ns	V <sub>DS</sub> =15V, I <sub>D</sub> =1A, V <sub>GS</sub> =10V, R <sub>G</sub> =3.3Ω
*tr	-	21	-		
*t <sub>d(OFF)</sub>	-	142	-		
*t <sub>f</sub>	-	84	-		
C <sub>iss</sub>	-	5385	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz
C <sub>oss</sub>	-	935	-		
C <sub>rss</sub>	-	854	-		
R <sub>g</sub>	-	1.6	4	Ω	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f=1MHz
<b>Source-Drain Diode</b>					
*I <sub>s</sub>	-	-	203	A	
*I <sub>SM</sub>	-	-	600		
*V <sub>SD</sub>	-	0.79	1.2	V	I <sub>s</sub> =20A, V <sub>GS</sub> =0V

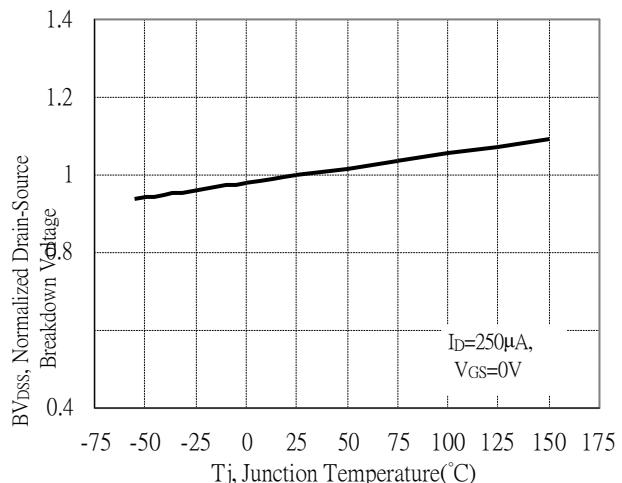
\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

## Typical Characteristics

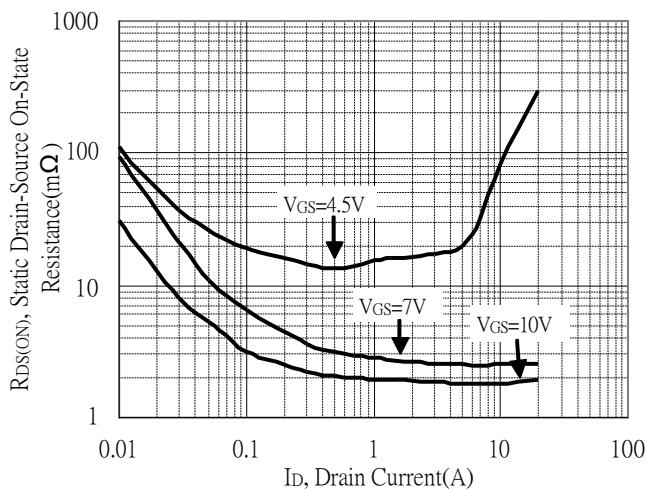
Typical Output Characteristics



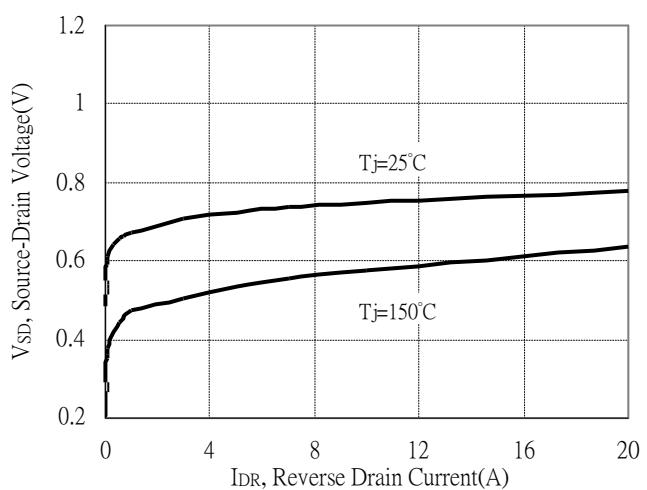
Breakdown Voltage vs Ambient Temperature



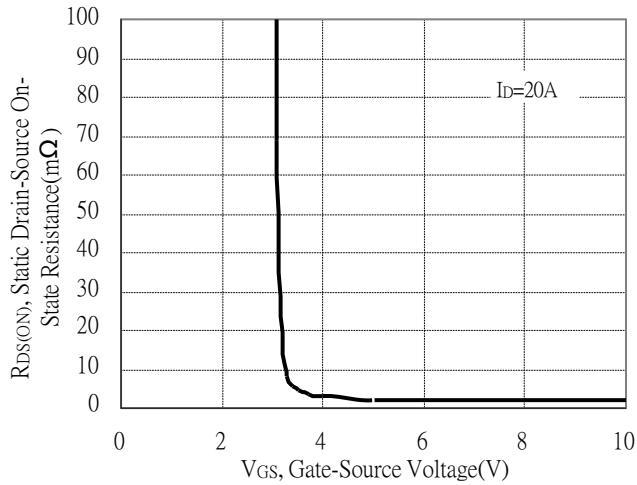
Static Drain-Source On-State resistance vs Drain Current



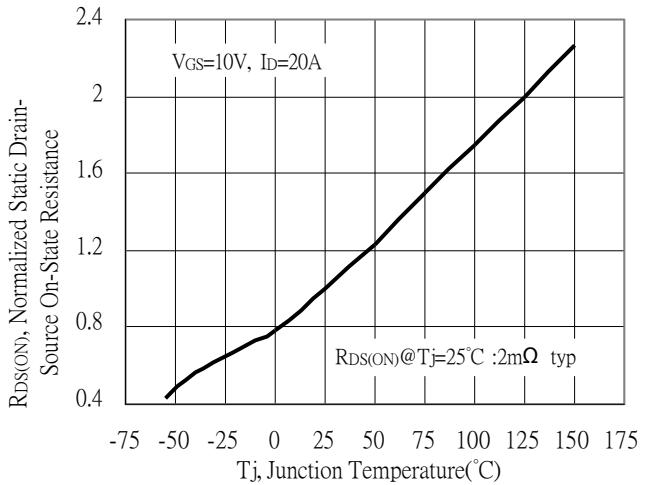
Reverse Drain Current vs Source-Drain Voltage



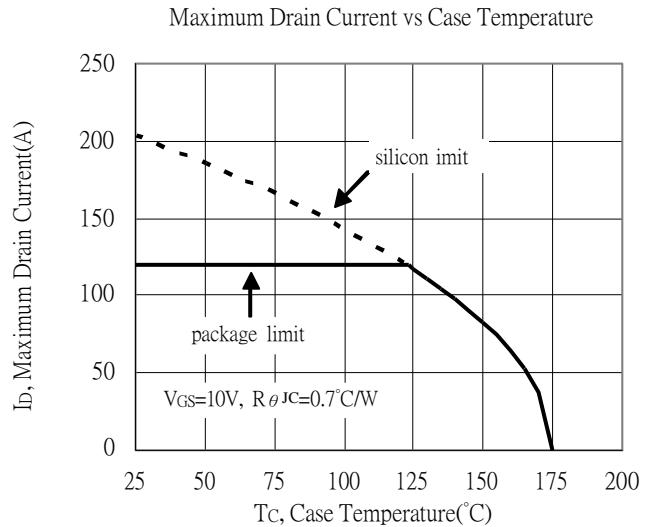
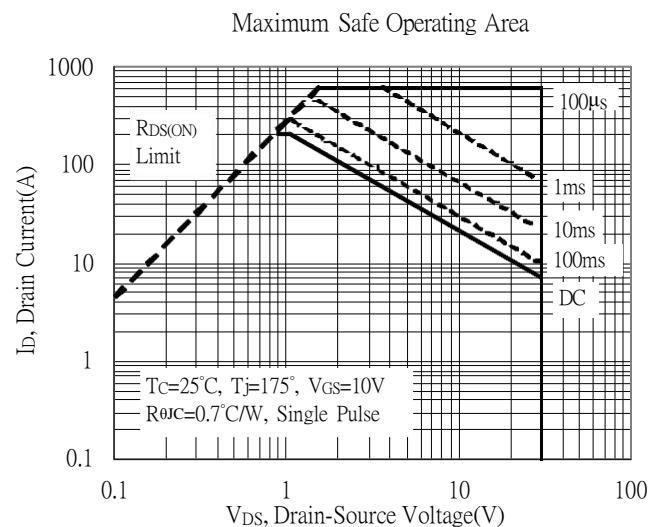
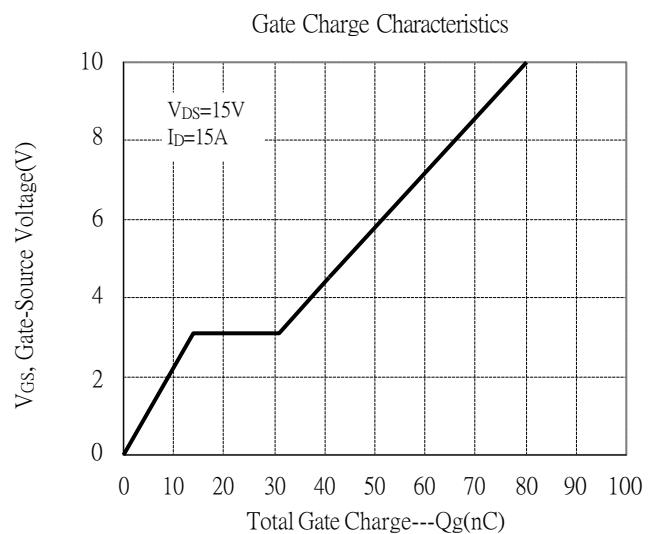
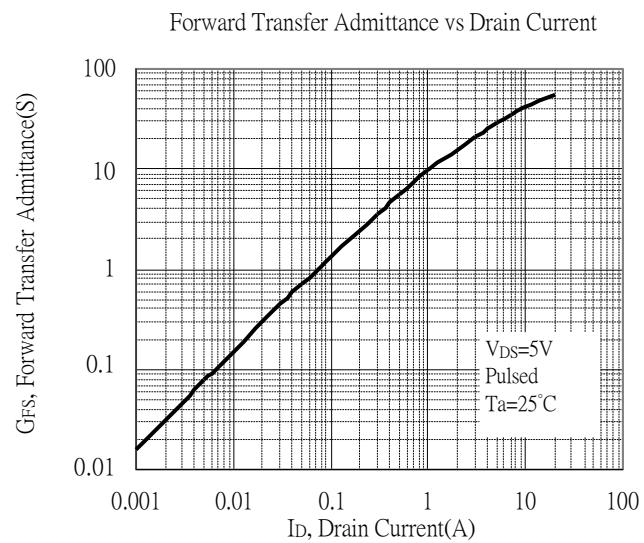
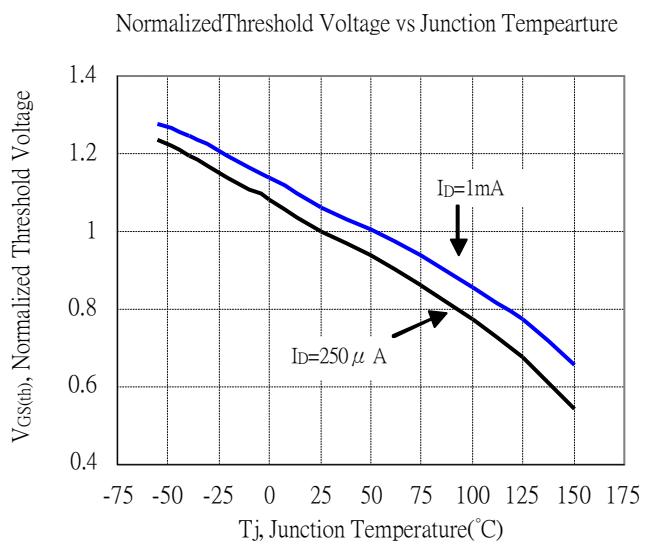
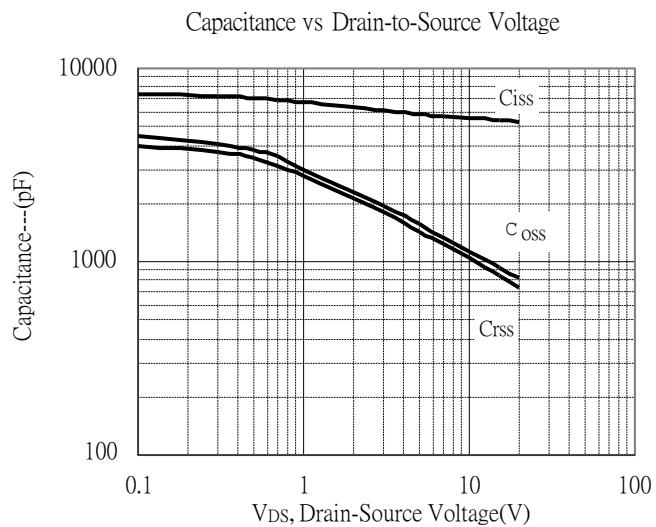
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

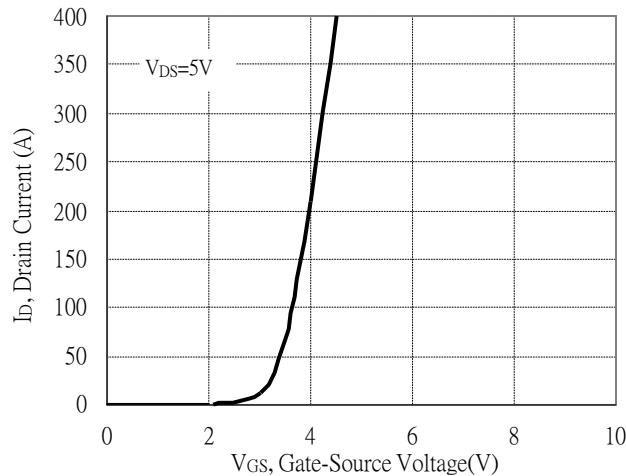


## Typical Characteristics(Cont.)

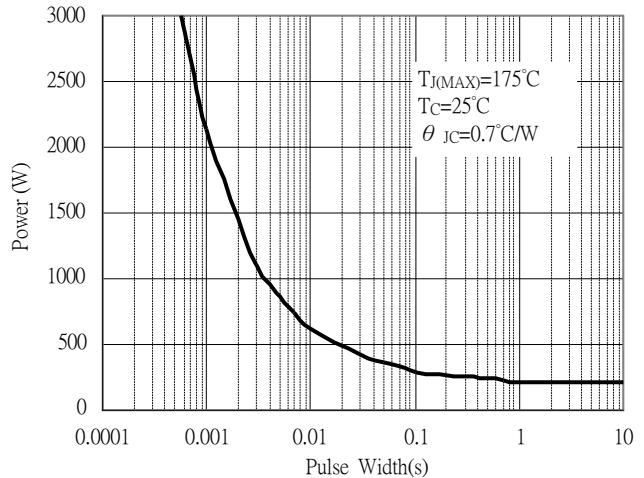


## Typical Characteristics(Cont.)

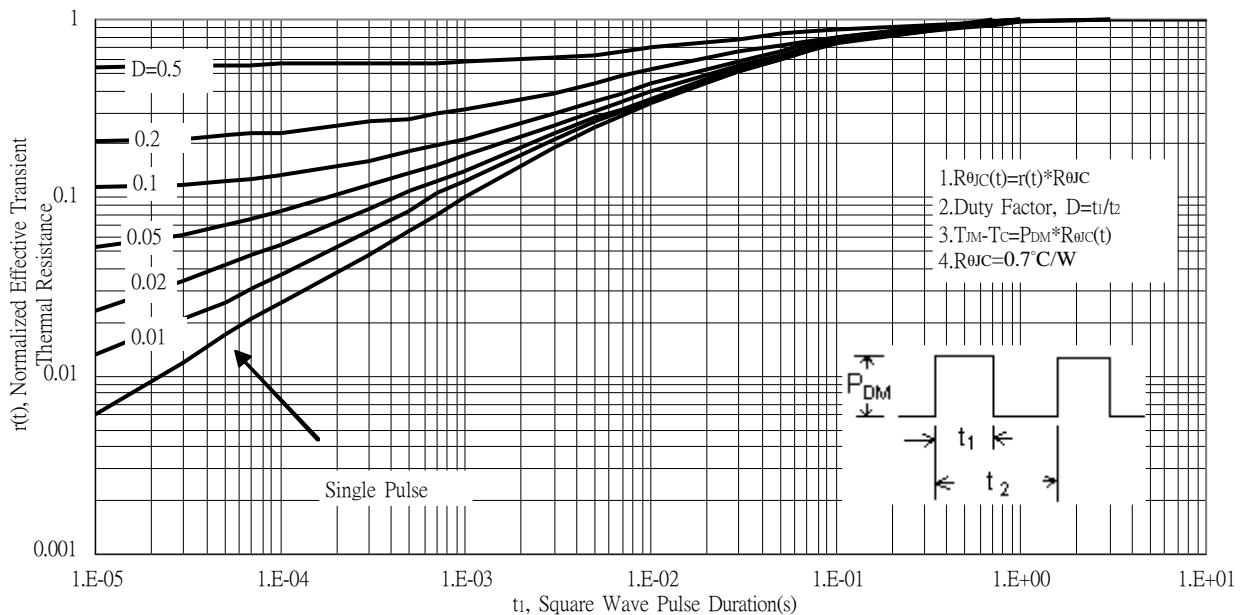
Typical Transfer Characteristics



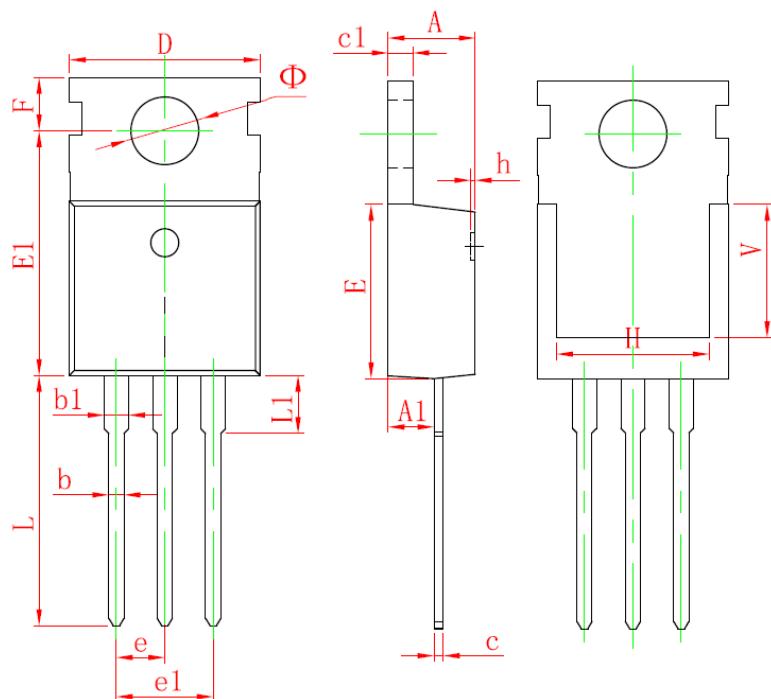
Single Pulse Maximum Power Dissipation



Transient Thermal Response Curves

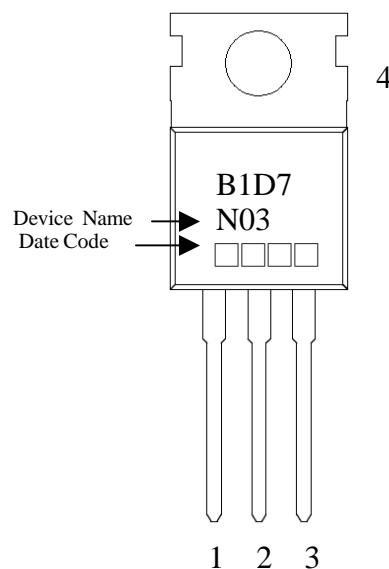


## TO-220 Dimension



3-Lead TO-220 Plastic Package  
 Package Code: E3

Marking:



Style: Pin 1.Gate 2.Drain 3.Source  
 4.Drain

\*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181	e	2.540*		0.100*	
A1	2.250	2.550	0.089	0.100	e1	4.980	5.180	0.196	0.204
b	0.710	0.910	0.028	0.036	F	2.650	2.950	0.104	0.116
b1	1.170	1.370	0.046	0.054	H	7.900	8.100	0.311	0.319
c	0.330	0.650	0.013	0.026	h	0.000	0.300	0.000	0.012
c1	1.200	1.400	0.047	0.055	L	12.900	13.400	0.508	0.528
D	9.910	10.250	0.390	0.404	L1	2.850	3.250	0.112	0.128
E	8.950	9.750	0.352	0.384	V	7.500	REF	0.295	REF
E1	12.650	12.950	0.498	0.510	Φ	3.400	3.800	0.134	0.150